# International Rectifier

IRF640N IRF640NS IRF640NL

HEXFET® Power MOSFET

- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Ease of Paralleling
- Simple Drive Requirements

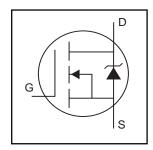
#### **Description**

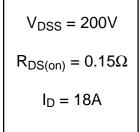
Fifth Generation HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

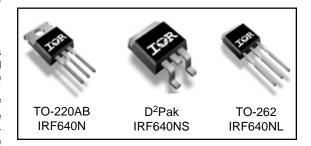
The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible onresistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF640NL) is available for low-







#### Absolute Maximum Ratings

	Parameter	Max.	Units	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	18		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	13	A	
I <sub>DM</sub>	Pulsed Drain Current ①	72		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	150	W	
	Linear Derating Factor	1.0	W/°C	
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V	
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>②</sup>	247	mJ	
I <sub>AR</sub>	Avalanche Current①	18	А	
E <sub>AR</sub>	Repetitive Avalanche Energy①	15	mJ	
dv/dt	Peak Diode Recovery dv/dt ©	8.1	V/ns	
TJ	Operating Junction and	-55 to +175		
T <sub>STG</sub>	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )		
	Mounting torque, 6-32 or M3 srew⊕	10 lbf•in (1.1N•m)		

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## Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

	<del>-</del>	-				•		
	Parameter	Min.	Тур.	Max.	Units	Conditions		
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_D = 250\mu A$		
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.25		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA		
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.15	Ω	V <sub>GS</sub> = 10V, I <sub>D</sub> = 11A ③		
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$		
g <sub>fs</sub>	Forward Transconductance	6.8			S	V <sub>DS</sub> = 50V, I <sub>D</sub> = 11A ③		
I <sub>DSS</sub>	Drain-to-Source Leakage Current			25	μA	V <sub>DS</sub> = 200V, V <sub>GS</sub> = 0V		
פפטי	Brain to Godroe Edakage Garrent			250	μΛ	V <sub>DS</sub> = 160V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 150°C		
lass	Gate-to-Source Forward Leakage			100	nA .	V <sub>GS</sub> = 20V		
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100		V <sub>GS</sub> = -20V		
Q <sub>g</sub>	Total Gate Charge			67		I <sub>D</sub> = 11A		
Q <sub>gs</sub>	Gate-to-Source Charge			11	nC	V <sub>DS</sub> = 160V		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			33		$V_{GS}$ = 10V, See Fig. 6 and 13		
t <sub>d(on)</sub>	Turn-On Delay Time		10			V <sub>DD</sub> = 100V		
t <sub>r</sub>	Rise Time		19		ns	$I_D = 11A$ $R_G = 2.5\Omega$		
t <sub>d(off)</sub>	Turn-Off Delay Time		23		115			
t <sub>f</sub>	Fall Time		5.5			$R_D = 9.0\Omega$ , See Fig. 10 ③		
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,		
<b>-</b> U	Thermal Brain maddane				nH	6mm (0.25in.)		
L <sub>S</sub>	Internal Source Inductance		7.5		''''	from package		
						and center of die contact		
C <sub>iss</sub>	Input Capacitance		1160			$V_{GS} = 0V$		
C <sub>oss</sub>	Output Capacitance		185			$V_{DS} = 25V$		
C <sub>rss</sub>	Reverse Transfer Capacitance		53		pF	f = 1.0MHz, See Fig. 5		

## **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current			18		MOSFET symbol	
	(Body Diode)	10		10	10 A	showing the	
I <sub>SM</sub>	Pulsed Source Current			72		integral reverse	
	(Body Diode)①					p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 11A$ , $V_{GS} = 0V$ ③	
t <sub>rr</sub>	Reverse Recovery Time		167	251	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 11A	
Q <sub>rr</sub>	Reverse Recovery Charge		929	1394	nC	di/dt = 100A/µs ③	
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )					

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.0	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface 4	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient@		62	
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)®		40	

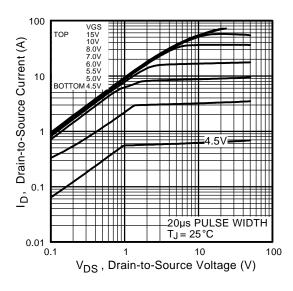


Fig 1. Typical Output Characteristics

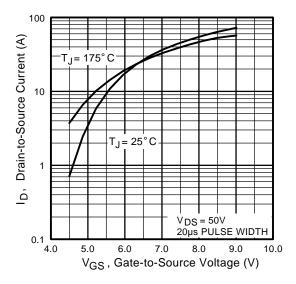


Fig 3. Typical Transfer Characteristics

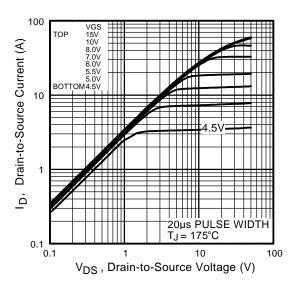
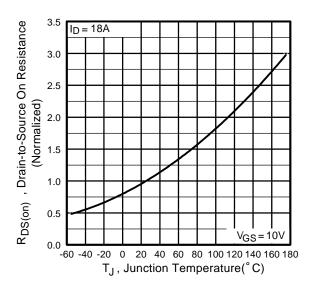


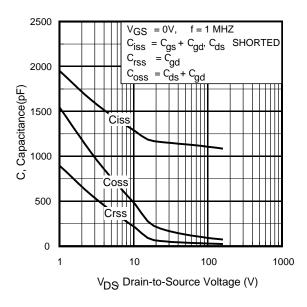
Fig 2. Typical Output Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature

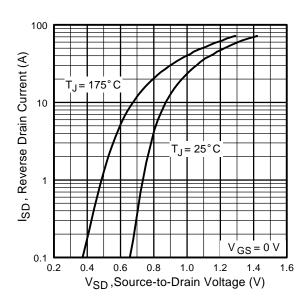
International

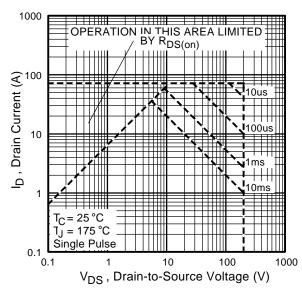
TOR Rectifier



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



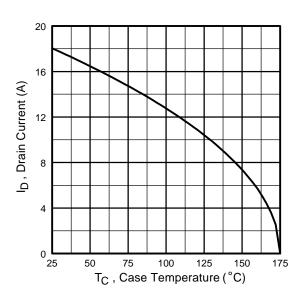


**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

# International TOR Rectifier

# IRF640N/S/L



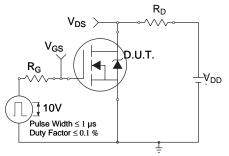
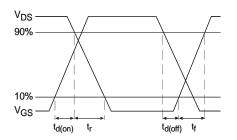


Fig 10a. Switching Time Test Circuit



**Fig 9.** Maximum Drain Current Vs. Case Temperature

Fig 10b. Switching Time Waveforms

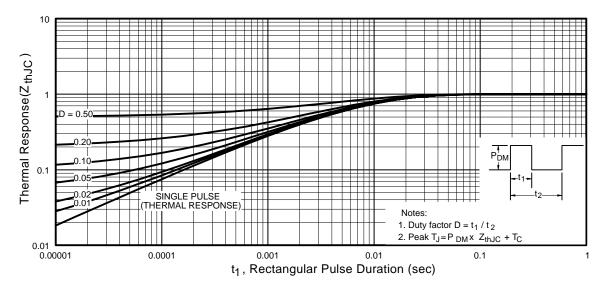


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

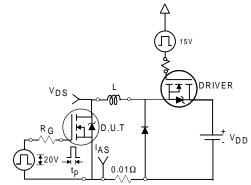


Fig 12a. Unclamped Inductive Test Circuit

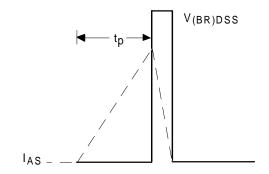


Fig 12b. Unclamped Inductive Waveforms

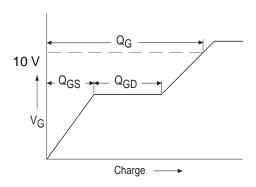
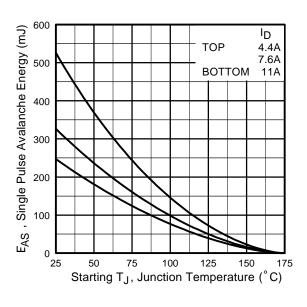


Fig 13a. Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

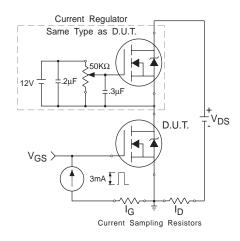
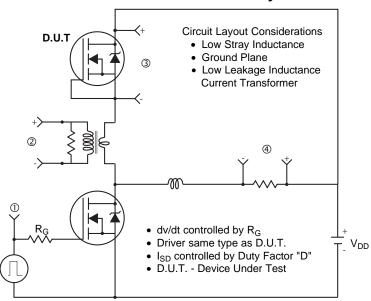
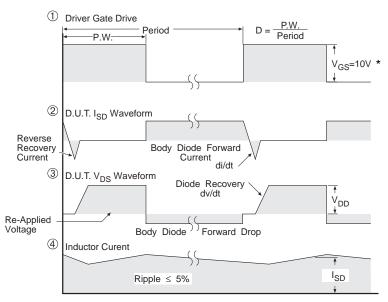


Fig 13b. Gate Charge Test Circuit

#### Peak Diode Recovery dv/dt Test Circuit





\* V<sub>GS</sub> = 5V for Logic Level Devices

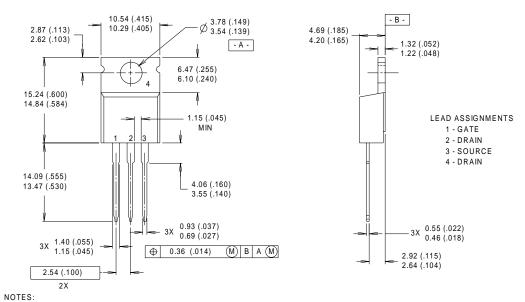
Fig 14. For N-Channel HEXFET® Power MOSFETs

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TOR Rectifier

#### TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION: INCH

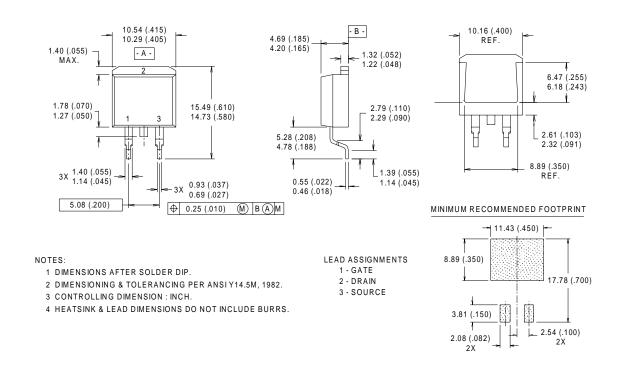
- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

### TO-220AB Part Marking Information

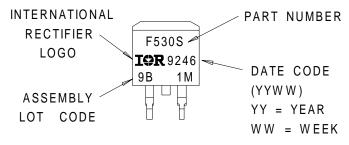
EXAMPLE: THIS IS AN IRF1010

WITH ASSEMBLY LOT CODE 9B1M INTERNATIONAL
RECTIFIER
LOGO
INTER 9246
9B 1M
DATE CODE
(YYWW)
YY = YEAR
WW = WEEK

## D<sup>2</sup>Pak Package Outline

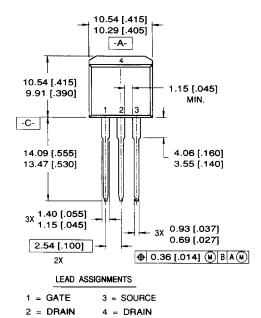


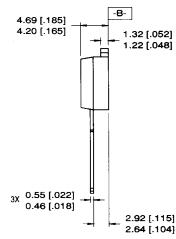
## D<sup>2</sup>Pak Part Marking Information





#### TO-262 Package Outline





#### NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. HEATSINK & LEAD DIMENSIONS DO NOT INCLUDE BURRS.

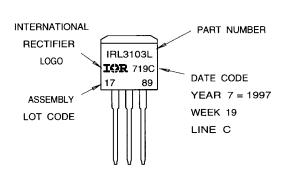
#### TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L

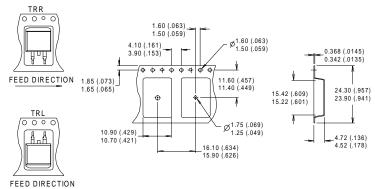
LOT CODE 1789

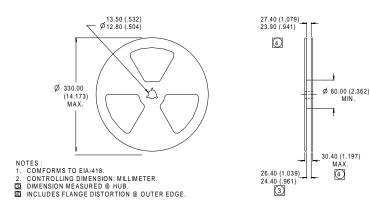
ASSEMBLED ON WW 19, 1997

IN THE ASSEMBLY LINE "C"



## D<sup>2</sup>Pak Tape & Reel Information





#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\label{eq:starting} \begin{tabular}{ll} \beg$
- ④ This is only applied to TO-220AB package
- ⑤ This is applied to D<sup>2</sup>Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ⑥  $I_{SD} \le 11A$ ,  $di/dt \le 344A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J \le 175$ °C

# International Rectifier

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Data and specifications subject to change without notice. 10/00